TEST REPORT

Report No.:	BCTC2312002085E
Applicant:	Shenzhen bodun baili electronics co., ltd.
Product Name:	DC POWER SUPPLY
Test Model:	R-SPS3020
Tested Date:	2023-12-22 to 2024-01-15
Issued Date:	2024-01-19

Shenzhen BCTC Testing Co., Ltd.

Product Name:	DC POWER SUPPLY
Trademark:	N/A
Model/Type Reference:	R-SPS3020 R-SPS6010, R-SPS3030, R-SPS1560, R-SPS1505, R-SPS6020, R-SPS1005, R-SPS10010, R-SPS12010, R-SPS2005, R-SPS3020C, R-SPS6010C, R-SPS3030C, R-SPS1560C, R-SPS1505C, R-SPS6020C, R-SPS1005C, R-SPS10010C, R-SPS12010C, R-SPS2005C, R-SPS3050, R-SPS3060, R-SPS6030, R-SPS15100, R-SPS10020, R-SPS15010, R-SPS20010, R-SPS3005, R-SPS30100, R-SPS10030, R-SPS6050, R-SPS5060
Prepared For:	Shenzhen bodun baili electronics co., ltd.
Address:	Room 205, Antian Building, Kaitian Science Park, Fumin Industrial Zone, Pinghu Street, Longgang, Shenzhen, Guangdong, China.
Manufacturer:	Shenzhen bodun baili electronics co., ltd.
Address:	Room 205, Antian Building, Kaitian Science Park, Fumin Industrial Zone, Pinghu Street, Longgang, Shenzhen, Guangdong, China.
Prepared By:	Shenzhen BCTC Testing Co., Ltd.
Address:	1-2/F., Building B, Pengzhou Industrial Park, No.158, Fuyuan 1st Road, Zhancheng, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China.
Sample Received Date:	2023-12-22
Sample Tested Date:	2023-12-22 to 2024-01-15
Issue Date:	2024-01-19
Report No.:	BCTC2312002085E
Test Standards:	EN 55032:2015+A11:2020+A1:2020, EN 55035:2017+A11:2020 EN IEC 61000-3-2:2019+A1:2021, EN 61000-3-3:2013+A2:2021
Test Results:	PASS

Tested by:

Jack Lee/ Project Handler

Approved by:

Zero Zhou/Reviewer

The test report is effective only with both signature and specialized stamp.This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen BCTC Testing Co., Ltd, this report can't be reproduced except in full.The tested sample(s) and the sample information are provided by the client.

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(Note: N/A means not applicable)

1. Version

Report No.	Issue Date	Description	Approved
BCTC2312002085E	2024-01-19	Original	Valid

2. Test Summary

The Product has been tested according to the following specifications:

Emission		
Standard	**Test Item**	**Test result**
EN 55032	Conducted emissions from the AC mains power ports	Pass
EN 55032	Asymmetric mode conducted emissions	N/A[1]
EN 55032	Conducted differential voltage emissions	N/A[2]
EN 55032	Radiated emissions	Pass
EN IEC 61000-3-2	Harmonic current emission(H)	Pass
EN 61000-3-3	Voltage fluctuations & flicker(F)	Pass

Immunity (EN 55035)		
Standard	**Test Item**	**Test result**
EN 55035	Electrostatic discharge (ESD)	Pass
EN 55035	Continuous RF electromagnetic field disturbances(RS)	Pass
EN 55035	Electrical fast transients/burst (EFT)	Pass
EN 55035	Surges	Pass
EN 55035	Continuous induced RF disturbances (CS)	Pass
EN 55035	Broadband impulse noise disturbances, repetitive	N/A[3]
EN 55035	Broadband impulse noise disturbances, isolated	N/A[3]
EN 55035	Power frequency magnetic field (PFMF)	N/A[4]
EN 55035	Voltage dips and interruptions (DIPS)	Pass

Remark:
1. Applicable to ports listed above and intended to connect to cables longer than 3 m.
2. The Product has no antenna port.
3. Applicable only to CPE xDSL ports.
4. The Product doesn't contain any device susceptible to magnetic fields.

3. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test item	Value (dB)
Conducted Emission (150kHz-30MHz)	3.10
Radiated Emission(30MHz~200MHz)	4.60
Radiated Emission(200MHz~1GHz)	5.20
Radiated Emission(1GHz~6GHz)	5.20

4. Product Information And Test Setup

4.1 Product Information

Ratings: Input: AC100V/AC240V 600W
Model difference: All models are identical except for the appearance color and model named.

4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

No.	Device Type	Brand	Model	Series No.	Note
1.	---	---	---	---	---

Notes:
1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

4.4 Test Mode

Test item	Test Mode	Test Voltage
Conducted emissions from the AC mains power ports (150KHz-30MHz) Class B	Full load	AC 230V/50Hz
Radiated emissions(30MHz-1GHz) Class B	Full load	AC 230V/50Hz
Harmonic current emission Class __A___	Full load	AC 230V/50Hz
Voltage fluctuations & flicker(F)	Full load	AC 230V/50Hz
Electrostatic discharge (ESD) ☒Air Discharge: ±2,4,8kV ☒Contact Discharge: ±2,4kV ☒HCP & VCP: ±2,4kV 10 times each point	Full load	AC 230V/50Hz
Continuous RF electromagnetic field disturbances(RS) A 80MHz-1000MHz, 1800MHz, 2600MHz,3500MHz,5000MHz 3V/m,80% AM Front, Rear, Left, Right H/V	Full load	AC 230V/50Hz
Electrical fast transients/burst (EFT) ☒1kV AC(Input) ☐0.5kV DC(Input) ☐0.5kV signal,Telec,control	Full load	AC 230V/50Hz
Surges ☒1kV Line-Line, ☒2kV Line-PE, N-PE ☐0.5kVDC(Input) ☐1KV,☐4KV signal,Telec, control Line-Line:90°+1kV,270°-1kV Line-PE:90°+2kV,270°-2kV N-PE:90°-2kV,270°+2kV	Full load	AC 230V/50Hz
Continuous induced RF disturbances (CS) A 0.15MHz to 10MHz 3V, 10MHz-30MHz 3 to 1V, 30MHz-80MHz 1V ☒ AC(Input) ☐ DC(Input) ☐ signal, Telec, control	Full load	AC 230V/50Hz
Voltage dips and interruptions (DIPS) Less 5% 0.5P 10ms B 70% 25P 500ms C Voltage Interruptions less5% 250P 5000ms C	Full load	AC 230V/50Hz

5. Test Facility And Test Instrument Used

5.1 Test Facility

All measurement facilities used to collect the measurement data are located at Shenzhen BCTC Testing Co., Ltd. Address: 1-2/F., Building B, Pengzhou Industrial Park, No.158, Fuyuan 1st Road, Zhancheng, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

5.2 Test Instrument Used

Conducted Emissions Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
Receiver	R&S	ESR3	102075	May 15, 2023	May 14, 2024
LISN	R&S	ENV216	101375	May 15, 2023	May 14, 2024
Software	Frad	EZ-EMC	EMC-CON 3A1	\	\
Pulse limiter	Schwarzbeck	VTSD 9561-F	01323	Sept. 22, 2023	Sept. 21, 2024

Radiated Emissions Test (966 Chamber#01)					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
966 chamber	ChengYu	966 Room	966	May 15, 2023	May 14, 2026
Receiver	R&S	ESRP	101154	May 15, 2023	May 14, 2024
Receiver	R&S	ESR3	102075	May 15, 2023	May 14, 2024
Amplifier	SKET	LAPA_01G18G-45dB	SK2021040901	May 15, 2023	May 14, 2024
Amplifier	Schwarzbeck	BBV9744	9744-0037	May 15, 2023	May 14, 2024
TRILOG Broadband Antenna	schwarzbeck	VULB9163	942	May 29, 2023	May 28, 2024
Horn Antenna	schwarzbeck	BBHA9120D	1541	May 31, 2023	May 30, 2024
Software	Frad	EZ-EMC	FA-03A2 RE	\	\

Harmonic / Flicker Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
Harmonic & Flicker Tester	LAPLACE	AC2000A	439263	May 15, 2023	May 14, 2024
AC Power Supply	KIKUSUI	PCR4000M	UK001879	May 15, 2023	May 14, 2024
Software	HTEC	H/F	V1.5	\	\

Electrostatic Discharge Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
ESD Tester	KIKUSUI	KES4201A	UH002321	May 15, 2023	May 14, 2024

Continuous RF Electromagnetic Field Disturbances Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
Power meter	Keysight	E4419	A00065	May 15, 2023	May 14, 2024
Power sensor	Keysight	E9300A	US39211659	May 15, 2023	May 14, 2024
Power sensor	Keysight	E9300A	US39211305	May 15, 2023	May 14, 2024
Amplifier	SKET	HAP_801000-250W	21201805013	May 15, 2023	May 14, 2024
Amplifier	SKET	HAP_0103-75W	21201805014	May 15, 2023	May 14, 2024
Amplifier	SKET	HAP_0306-50W	21201805015	May 15, 2023	May 14, 2024
Stacked double Log.-Per. Antenna	Schwarzbeck	STLP 9129	00077	\	\
Field Probe	Narda	EP-601	611WX80256	May 15, 2023	May 14, 2024
Signal Generator	Agilent	N5181A	MY50143748	May 15, 2023	May 14, 2024
Software	SKET	EMC-S	1.2.0.18	\	\

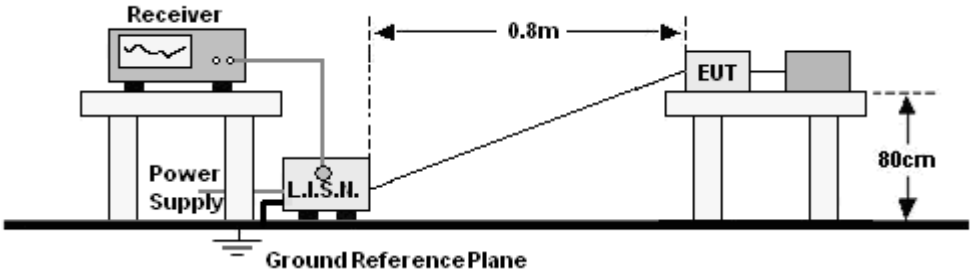
EFT And Surge And Voltage Dips And Interruptions Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
Compact Generator	TRANSIENT	TRA2000	646	May 15, 2023	May 14, 2024
Coupling Clamp	PARTNER	CN-EFT1000	CN-EFT1000-1624	May 15, 2023	May 14, 2024

Continuous Induced RF Disturbances Test					
Equipment	**Manufacturer**	**Model#**	**Serial#**	**Last Cal.**	**Next Cal.**
C/S Test System	SCHLODER	CDG-6000-75	126B1405/2016	May 15, 2023	May 14, 2024
Attenuator	SCHLODER	6DB DC-1G	HA1630	May 15, 2023	May 14, 2024
CDN	SCHLODER	CDN M2+M3	A2210389/2016	May 15, 2023	May 14, 2024
Injection Clamp	SCHLOBER	EMCL-20	132A1272/2016	May 15, 2023	May 14, 2024
Software	HUBERT	HUBERTEN 61000-4-6	1.4.1.0	\	\

6. Conducted Emissions

6.1 Block Diagram Of Test Setup

For mains ports:



6.2 Limit

Limits for Conducted emissions at the mains ports of Class B MME

Frequency range (MHz)	Limits dB(μV)	
	Quasi-peak	Average
0,15 to 0,50	66 to 56*	56 to 46*
0,50 to 5	56	46
5 to 30	60	50

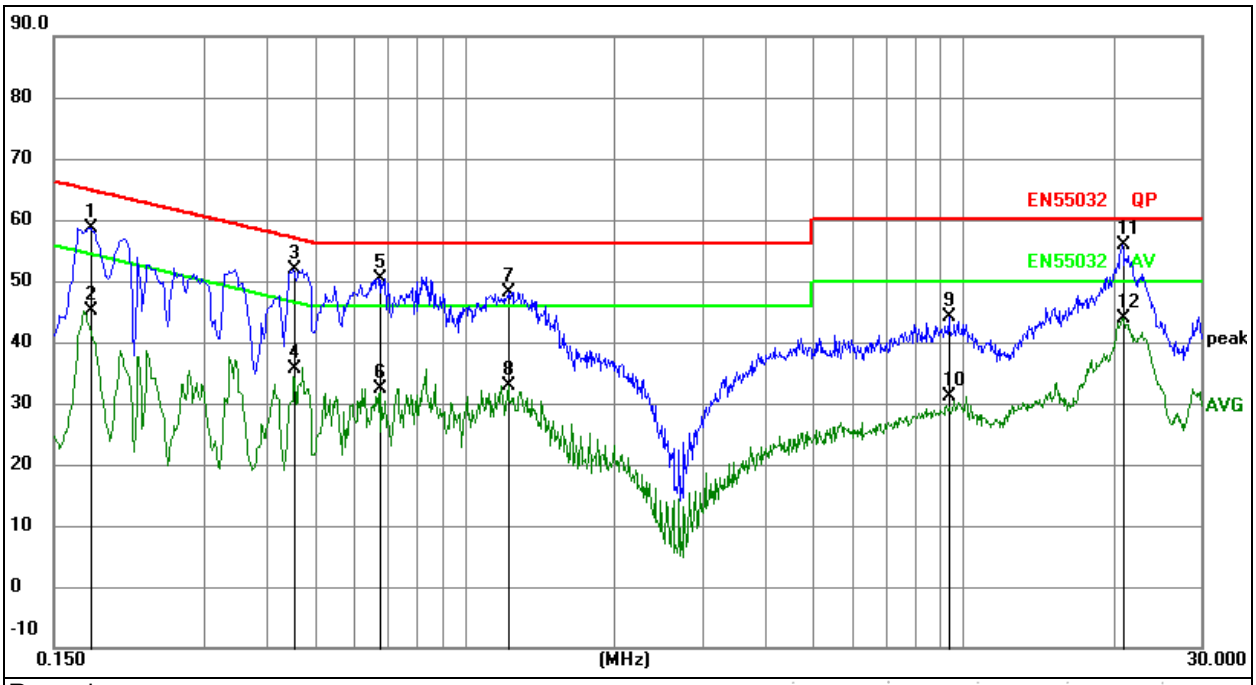
Notes: 1. *Decreasing linearly with logarithm of frequency.
2. The lower limit shall apply at the transition frequencies.

6.3 Test procedure

For mains ports:
a. The Product was placed on a nonconductive table 0. 8 m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).
b. The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.
c. For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.

6.4 Test Result

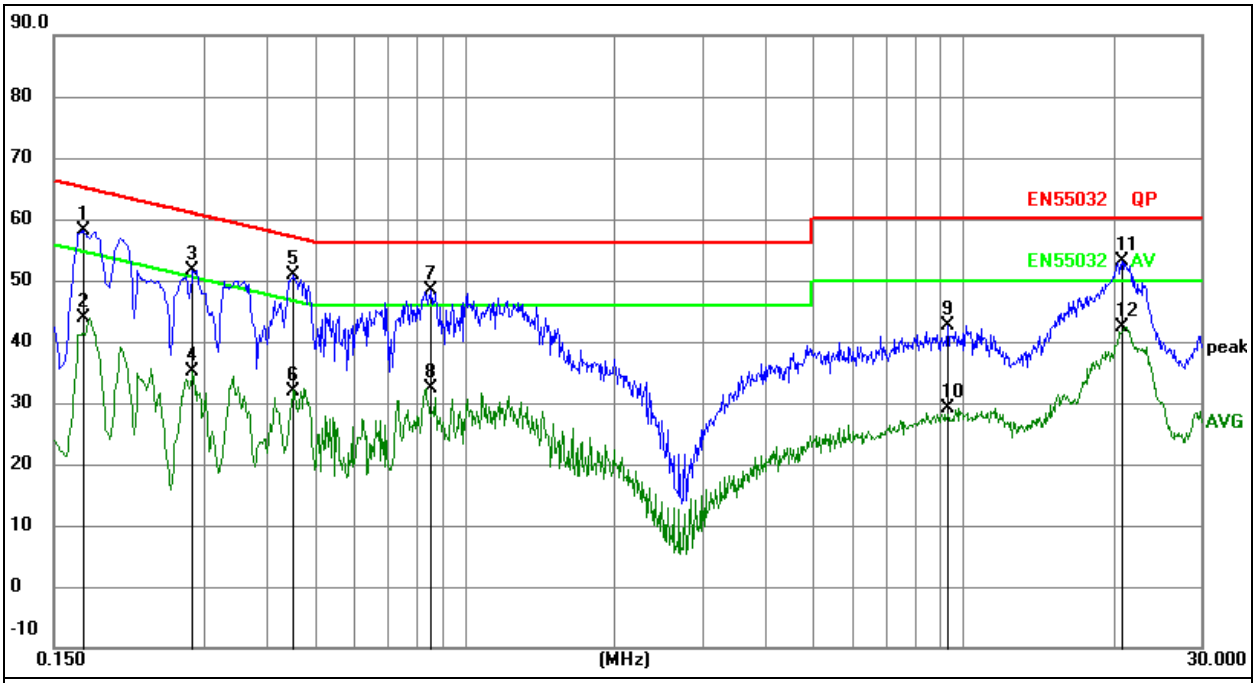
Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Phase :	Line
Test Voltage :	AC 230V/50Hz	Test Mode:	Full load



Remark:
1. All readings are Quasi-Peak and Average values.
2. Factor = Insertion Loss + Cable Loss.
3. Measurement = Reading Level + Correct Factor
4. Over = Measurement - Limit

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz		dB	dBuV	dBuV	dB	Detector
1		0.1770	38.92	19.78	58.70	64.63	-5.93	QP
2		0.1770	25.33	19.78	45.11	54.63	-9.52	AVG
3		0.4560	32.10	19.84	51.94	56.77	-4.83	QP
4		0.4560	15.91	19.84	35.75	46.77	-11.02	AVG
5		0.6719	30.60	19.84	50.44	56.00	-5.56	QP
6		0.6719	12.55	19.84	32.39	46.00	-13.61	AVG
7		1.2254	28.25	19.95	48.20	56.00	-7.80	QP
8		1.2254	12.87	19.95	32.82	46.00	-13.18	AVG
9		9.3660	24.13	19.90	44.03	60.00	-15.97	QP
10		9.3660	11.18	19.90	31.08	50.00	-18.92	AVG
11	*	20.8905	35.83	19.99	55.82	60.00	-4.18	QP
12		20.8905	24.01	19.99	44.00	50.00	-6.00	AVG

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Phase :	Neutral
Test Voltage :	AC 230V/50Hz	Test Mode:	Full load



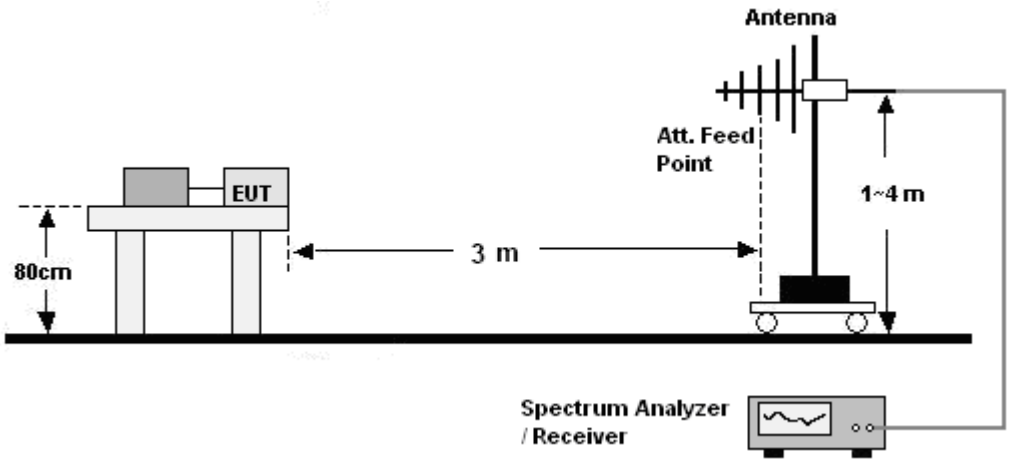
Remark:
1. All readings are Quasi-Peak and Average values.
2. Factor = Insertion Loss + Cable Loss.
3. Measurement = Reading Level + Correct Factor
4. Over = Measurement - Limit

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz		dB	dBuV	dBuV	dB	Detector
1		0.1720	38.39	19.77	58.16	64.86	-6.70	QP
2		0.1720	24.01	19.77	43.78	54.86	-11.08	AVG
3		0.2847	31.75	19.83	51.58	60.68	-9.10	QP
4		0.2847	15.37	19.83	35.20	50.68	-15.48	AVG
5	*	0.4539	31.16	19.84	51.00	56.80	-5.80	QP
6		0.4539	12.16	19.84	32.00	46.80	-14.80	AVG
7		0.8572	28.37	19.90	48.27	56.00	-7.73	QP
8		0.8572	12.38	19.90	32.28	46.00	-13.72	AVG
9		9.3023	22.74	19.90	42.64	60.00	-17.36	QP
10		9.3023	9.23	19.90	29.13	50.00	-20.87	AVG
11		20.8137	33.13	19.99	53.12	60.00	-6.88	QP
12		20.8137	22.39	19.99	42.38	50.00	-7.62	AVG

7. Radiated Emissions Test

7.1 Block Diagram Of Test Setup

30MHz ~ 1GHz:



7.2 Limits

Limits for radiated disturbance of Class B MME

Frequency (MHz)	Quasi-peak limits at 3m dB(μV/m)
30-230	40
230-1000	47

7.3 Test Procedure

30MHz ~ 1GHz:

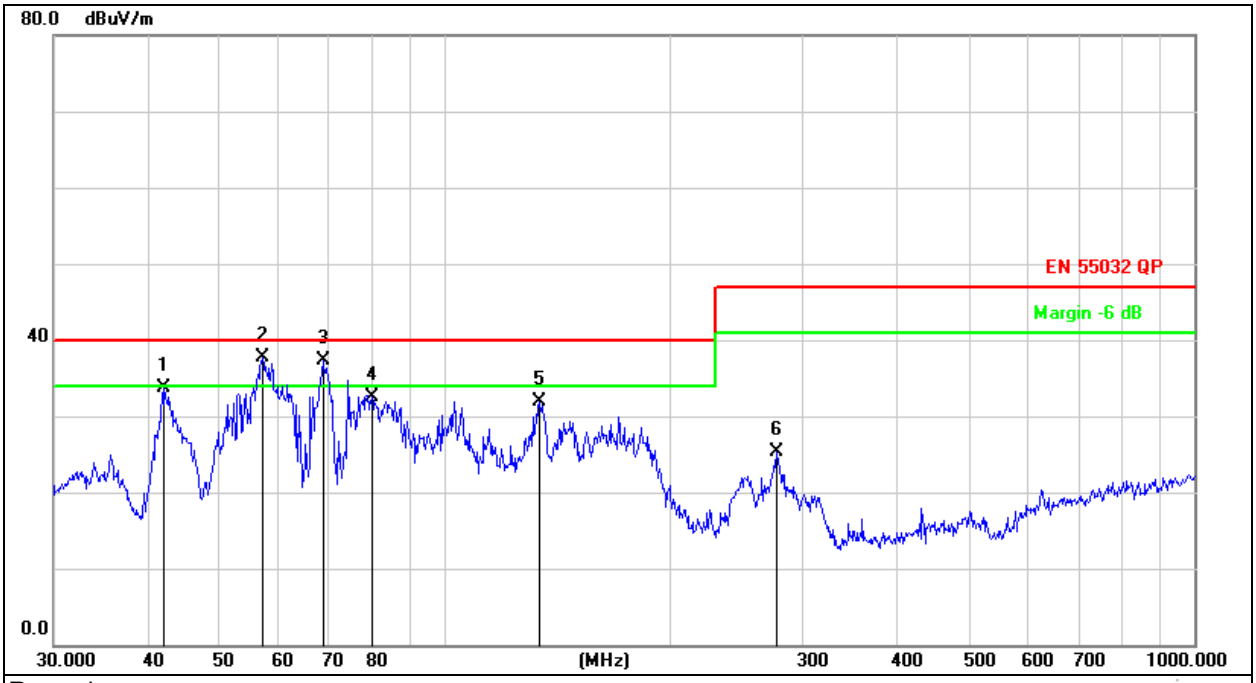
a. The Product was placed on the nonconductive turntable 0.8 m above the ground in a semi anechoic chamber.

b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.

c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

7.4 Test Results

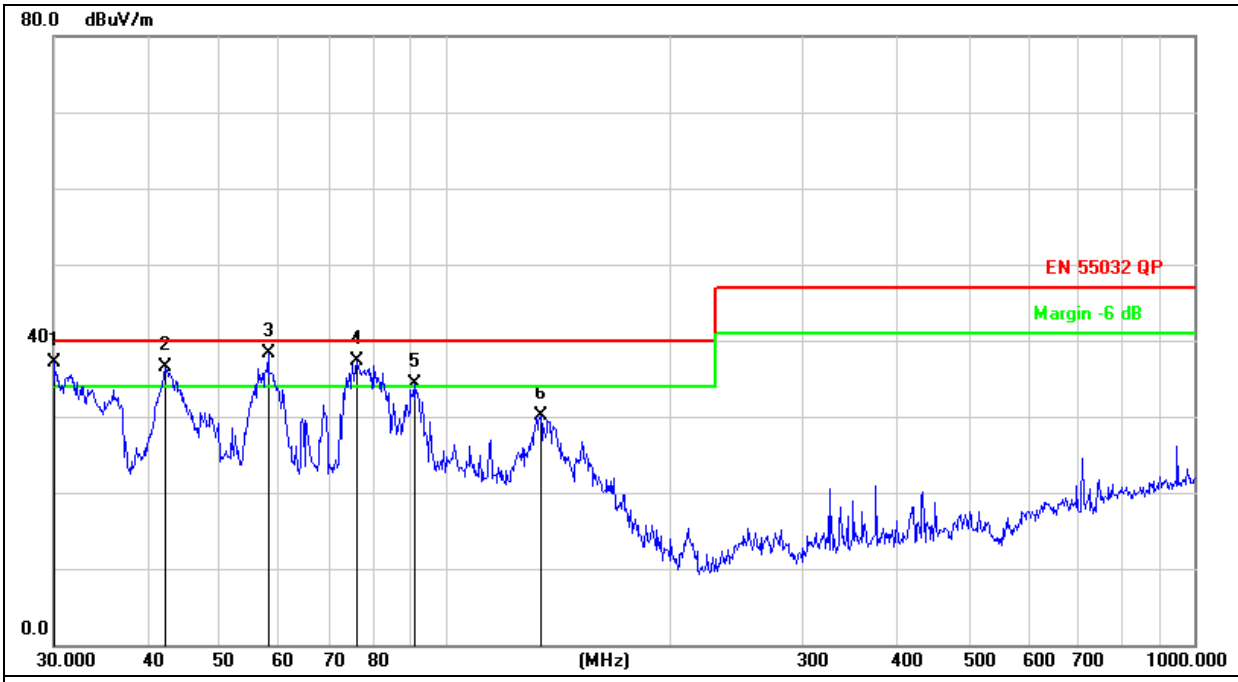
Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101KPa	Phase :	Horizontal
Test Voltage :	AC 230V/50Hz	Test Mode:	Full load



Remark:
1. Factor = Antenna Factor + Cable Loss – Pre-amplifier.
2. Measurement = Reading Level + Correct Factor
3. Over = Measurement - Limit

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
1		42.1542	48.21	-14.54	33.67	40.00	-6.33	QP
2	*	56.9911	52.54	-14.84	37.70	40.00	-2.30	QP
3	!	68.6310	54.96	-17.62	37.34	40.00	-2.66	QP
4		79.8002	52.16	-19.72	32.44	40.00	-7.56	QP
5		133.6186	50.20	-18.28	31.92	40.00	-8.08	QP
6		277.0935	39.10	-13.72	25.38	47.00	-21.62	QP

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101KPa	Phase :	Vertical
Test Voltage :	AC 230V/50Hz	Test Mode:	Full load

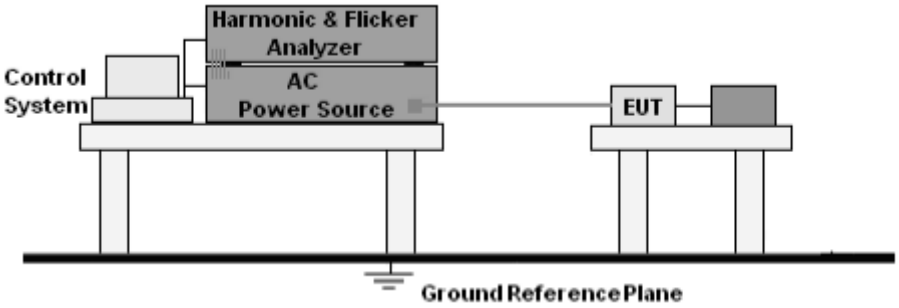


Remark:
1. Factor = Antenna Factor + Cable Loss – Pre-amplifier.
2. Measurement = Reading Level + Correct Factor
3. Over = Measurement - Limit

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
1	!	30.0000	53.83	-16.65	37.18	40.00	-2.82	QP
2	!	42.3021	50.97	-14.53	36.44	40.00	-3.56	QP
3	*	57.9992	53.38	-14.98	38.40	40.00	-1.60	QP
4	!	76.2442	56.31	-19.09	37.22	40.00	-2.78	QP
5	!	90.8554	51.57	-17.27	34.30	40.00	-5.70	QP
6		134.0882	48.44	-18.32	30.12	40.00	-9.88	QP

8. Harmonic Current Emission(H)

8.1 Block Diagram of Test Setup



8.2 Limit

EN IEC 61000-3-2:2019+A1:2021

8.3 Test Procedure

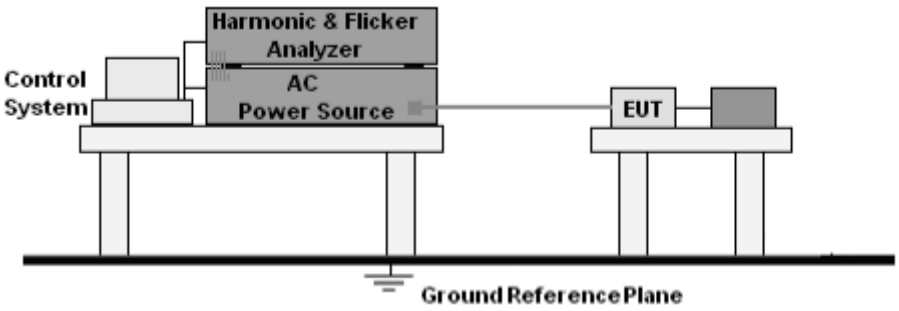
a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
b. The correspondent test program of test instrument to measure the current harmonics emanated from Product was chosen. The measure time shall be not less than the time necessary for the Product to be exercised.

8.4 Test Results

PASS

9. Voltage Fluctuations & Flicker(F)

9.1 Block Diagram of Test Setup



9.2 Limit

EN 61000-3-3:2013+A2:2021 Clause 5.

9.3 Test Procedure

a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
b. During the flick test, the measure time shall include that part of whole operation cycle in which the Product produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

9.4 Test Results

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Test Mode:	Full load
Test Voltage :	AC 230V/50Hz		

Test duration (sec):600

Describe:

Load Power : 0.497 kW **Power Factor:0.582**

Load Current : 3.677 Arms **Crest Factor:3.035**

Nominal Voltage : 229.19 Vrms

Test Result: pass **Status: Test Completed**

Result:

T-max (ms):	**0.00**	**Test limit (ms):**	**500.00**	**Pass**
Highest dc (%):	**0.00**	**Test limit (%):**	**3.30**	**Pass**
Highest dmax (%):	**0.00**	**Test limit (%):**	**4.00**	**Pass**
Highest Pst (10 min. period):	**0.00**	**Test limit:**	**1.00**	**Pass**

10. Immunity Test Of General The Performance Criteria

Product Standard	EN 55035: 2017+A11:2020 clause 8
CRITERION A	The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
CRITERION B	During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test. After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
CRITERION C	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

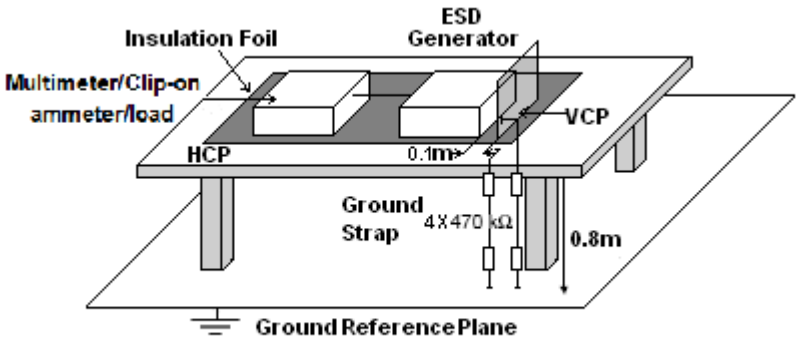
11. Electrostatic Discharge (ESD)

11.1 Test Specification

Basic standard	:	IEC 61000-4-2
Test Port	:	Enclosure port
Discharge Impedance	:	330 ohm / 150 pF
Discharge Mode	:	Single Discharge
Discharge Period	:	one second between each discharge

11.2 Block Diagram of Test Setup

For Floor Stand:



11.3 Test Procedure

a. Electrostatic discharges were applied only to those points and surfaces of the Product that are accessible to users during normal operation.
b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
c. The time interval between two successive single discharges was at least 1 second.
d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the Product.
e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the Product as fast as possible (without causing mechanical damage) to touch the Product. After each discharge, the ESD generator was removed from the Product and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
g. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the Product were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the Product.

11.4 Test Results

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Test Mode:	Full load
Test Voltage :	AC 230V/50Hz		

Discharge Method	Discharge Position	Voltage (±kV)	Min. No. of Discharge per polarity (Each Point)	Required Level	Performance Criterion
Contact Discharge	Conductive Surfaces	4	10	B	A
	Indirect Discharge HCP	4	10	B	A
	Indirect Discharge VCP	4	10	B	A
Air Discharge	Slots, Apertures, and Insulating Surfaces	8	10	B	A

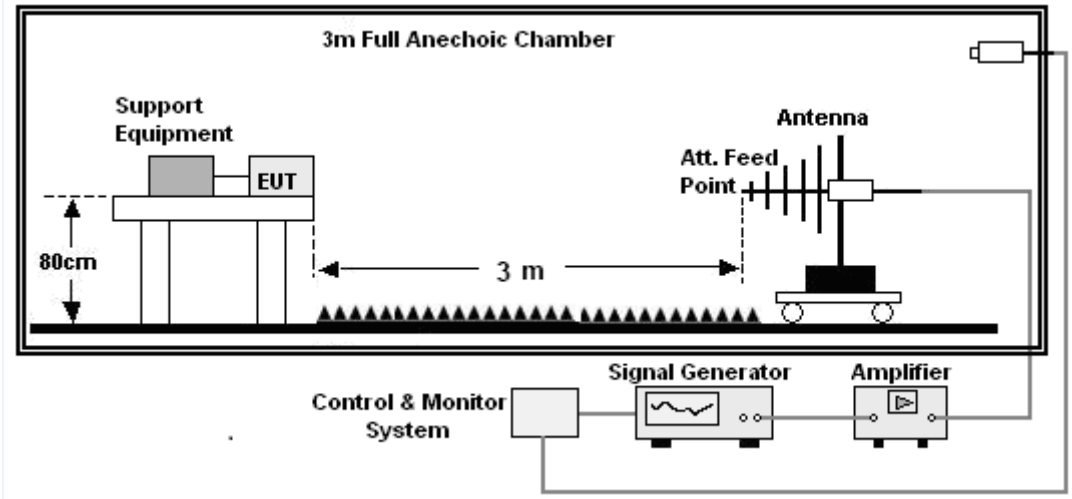
12. Continuous Rf Electromagnetic Field Disturbances (RS)

12.1 Test Specification

Basic standard	:	IEC 61000-4-3
Test Port	:	Enclosure port
Step Size	:	1%
Modulation	:	1kHz, 80% AM
Dwell Time	:	1 second
Polarization	:	Horizontal & Vertical

12.2 Block Diagram of Test Setup

Below 1GHz:



12.3 Test Procedure

a. The testing was performed in a fully-anechoic chamber. The transmit antenna was located at a distance of 3 meters from the Product.
b. The frequency range is swept from 80MHz to 1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz,with the signal 80% amplitude modulated with a 1 kHz sine wave,and the step size was 1%.
c. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to be able to respond, but should not exceed 5 s at each of the frequencies during the scan.
d. The test was performed with the Product exposed to both vertically and horizontally polarized fields on each of the four sides.
e. For Broadcast reception function:Group 2 not apply in this test.

12.4 Test Results

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Test Mode:	Full load
Test Voltage :	AC 230V/50Hz		

Frequency	Position	Field Strength (V/m)	Required Level	Performance Criterion
80 – 1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz	Front, Right, Back, Left	3	A	A

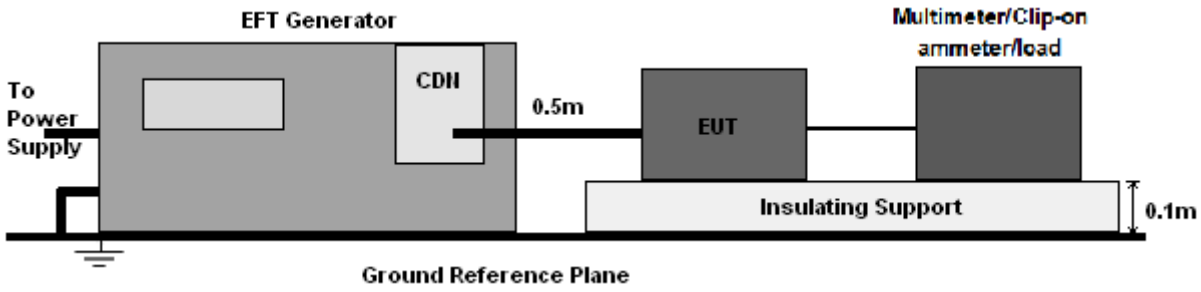
13. Electrical Fast Transients/Burst (EFT)

13.1 Test Specification

Basic standard	:	IEC 61000-4-4
Test Port	:	input ac/dc. Power port
.Impulse Frequency	:	5 kHz
Impulse Wave-shape	:	5/50 ns
Burst Duration	:	15 ms
Burst Period	:	300 ms
Test Duration	:	2 minutes per polarity

13.2 Block Diagram of EUT Test Setup

For input ac/dc. power port:



13.3 Test Procedure

a. The Product and support units were located on a non-conductive table above ground reference plane.

b. A 0.5m-long power cord was attached to Product during the test.

13.4 Test Results

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Test Mode:	Full load
Test Voltage :	AC 230V/50Hz		

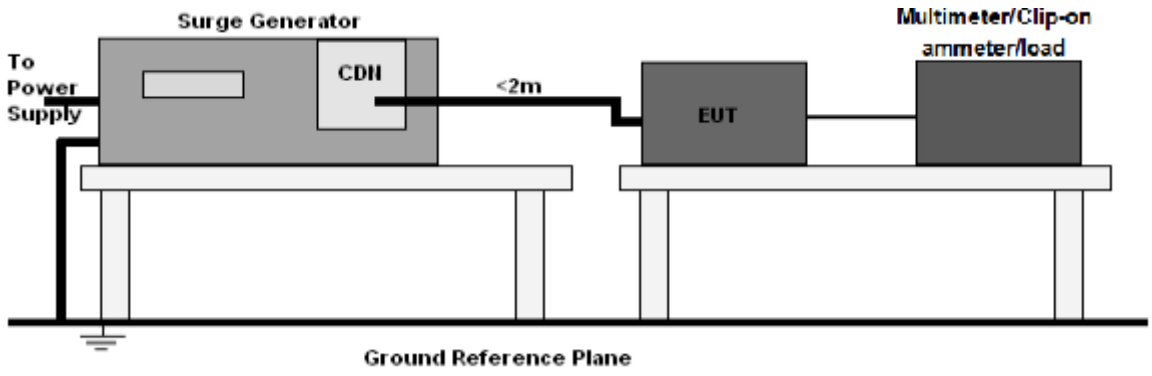
Coupling	Voltage (kV)	Polarity	Required Level	Performance Criterion
AC MainsL-N-P	1.0	±	B	A

14. Surges Immunity Test

14.1 Test Specification

Basic standard	:	IEC 61000-4-5
Test Port	:	input ac/dc. power port
Wave-Shape	:	Open Circuit Voltage - 1.2 / 50 us Short Circuit Current - 8 / 20 us
Pulse Repetition Rate	:	1 pulse / min.
Phase Angle	:	0° / 90° / 180° / 270°
Test Events	:	5 pulses (positive & negative) for each polarity

14.2 Block Diagram of EUT Test Setup



14.3 Test Procedure

a. The surge is to be applied to the Product power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave.
b. The power cord between the Product and the coupling/decoupling networks shall be 2 meters in length (or shorter). Interconnection line between the Product and the coupling/decoupling networks shall be 2 meters in length (or shorter).

14.4 Test Result

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Test Mode:	Full load
Test Voltage :	AC 230V/50Hz		

Coupling Line	Voltage (kV)	Phase Angle	Required Level	Performance Criterion
L - N	+ 1	90°	B	A
	- 1	270°		
L - PE	+ 2	90°	B	A
	- 2	270°		
N - PE	+ 2	90°	B	A
	- 2	270°		

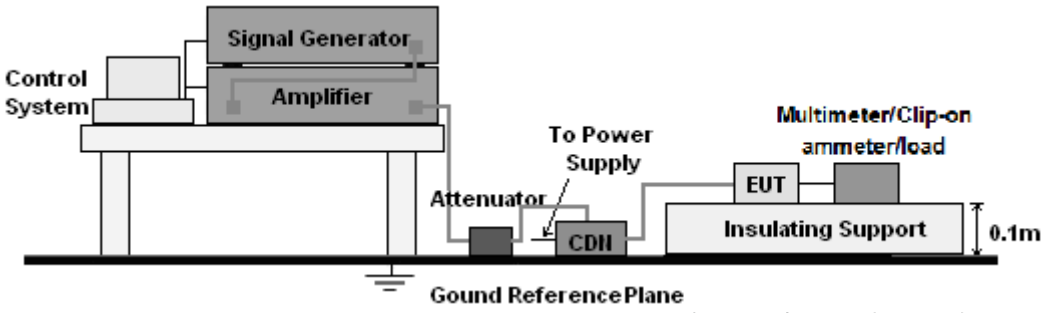
15. Continuous induced RF disturbances (CS)

15.1 Test Specification

Basic standard	:	IEC 61000-4-6
Test Port	:	input ac/dc. power port
Step Size	:	1%
Modulation	:	1kHz, 80% AM
Dwell Time	:	1 second

15.2 Block Diagram of EUT Test Setup

For input ac/ac. power port:



15.3 Test Procedure

For input ac/dc. power port:
a. The Product and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
b. The frequency range is swept from 150 kHz to 10MHz, 10MHz to 30MHz, 30MHz to 80MHz with the signal 80% amplitude modulated with a 1 kHz sine wave, and the step size was 1% of fundamental.
c. The dwell time at each frequency shall be not less than the time necessary for the Product to be able to respond.

15.4 Test Result

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Test Mode:	Full load
Test Voltage :	AC 230V/50Hz		

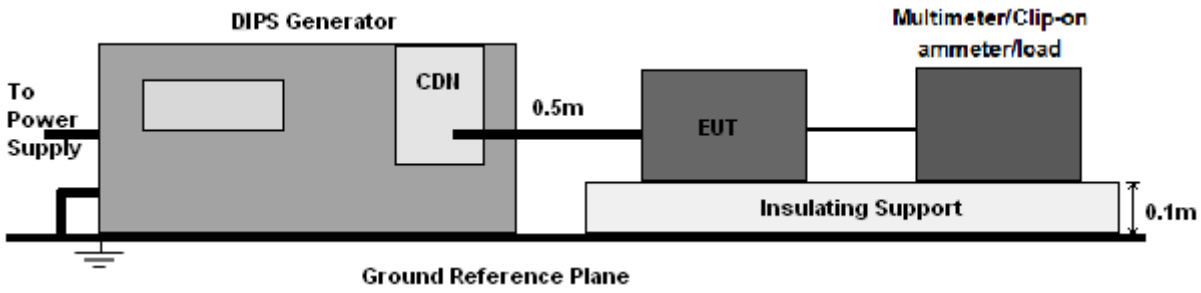
Inject Line	Frequency (MHz)	Voltage Level (V r.m.s.)	Required Level	Performance Criterion
a.c. port	0.15 - 10	3	A	A
	10 to 30	3 to 1	A	A
	30 to 80	1	A	A

16. Voltage dips and interruptions (DIPS)

16.1 Test Specification

Basic standard	:	IEC 61000-4-11
Test Port	:	input ac. power port
Phase Angle	:	0°, 180°
Test cycle	:	3 times

16.2 Block Diagram of EUT Test Setup



16.3 Test Procedure

a. The Product and support units were located on a non-conductive table above ground floor.
b. Set the parameter of tests and then perform the test software of test simulator.
c. Conditions changes to occur at 0 degree crossover point of the voltage waveform.

16.4 Test Result

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101kPa	Test Mode:	Full load
Test Voltage :	AC 230V/50Hz		

Test Level % U_T	Voltage dips in % U_T	Duration (ms)	Required Level	Performance Criterion
< 5	≥95	10	B	A
70	30	500	C	A
Voltage Interruptions:*				
< 5	≥95	5000	C	B*
Remark: T (s) = 1 / f (Hz).				
Note*: The EUT Unable to working during testing, and it end of the test can be restored automatically.				

17. EUT Photographs

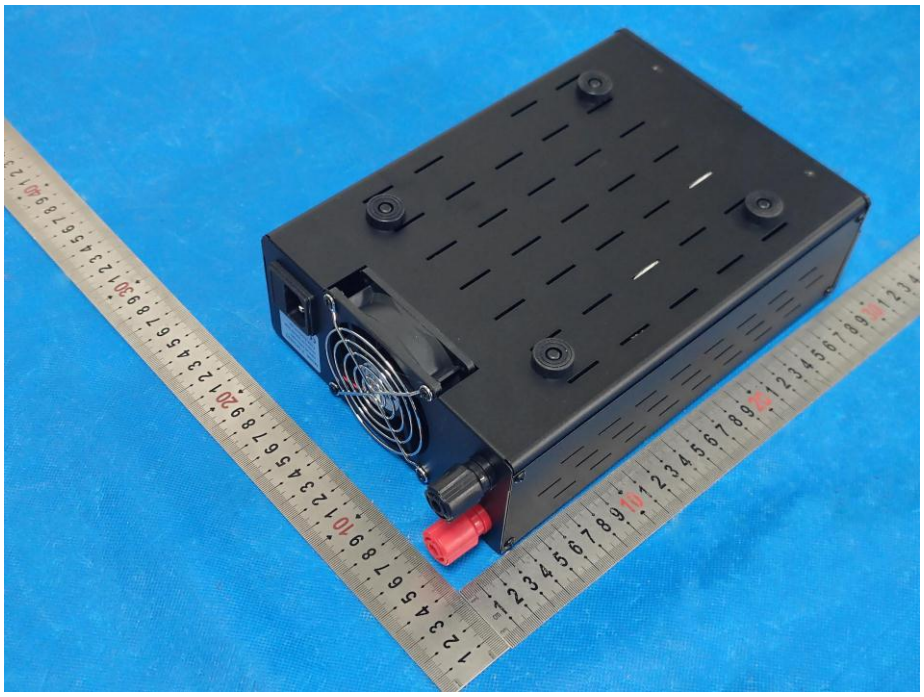
EUT Photo 1



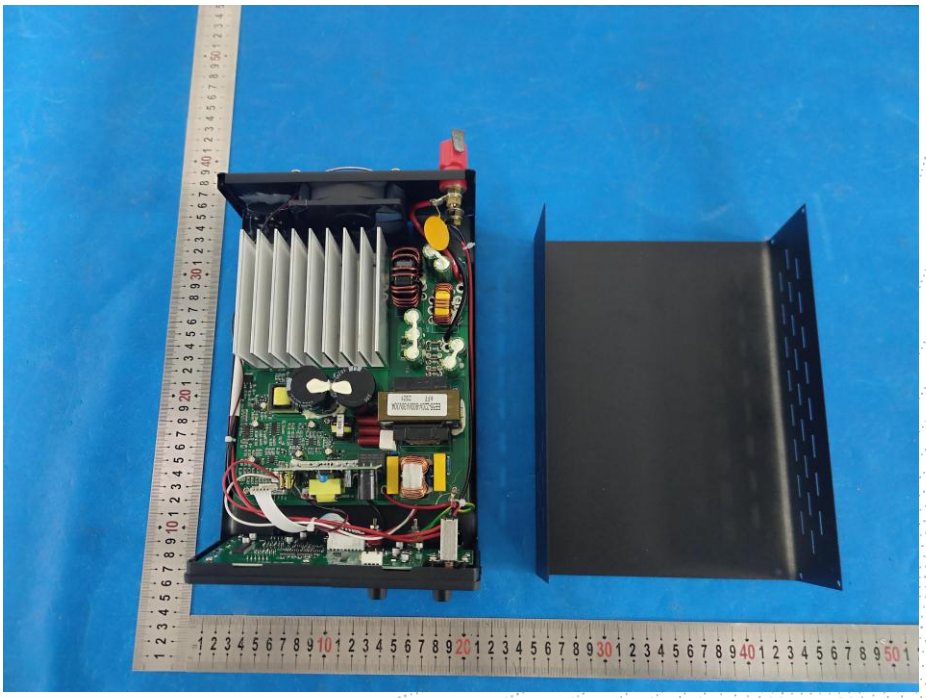
EUT Photo 2



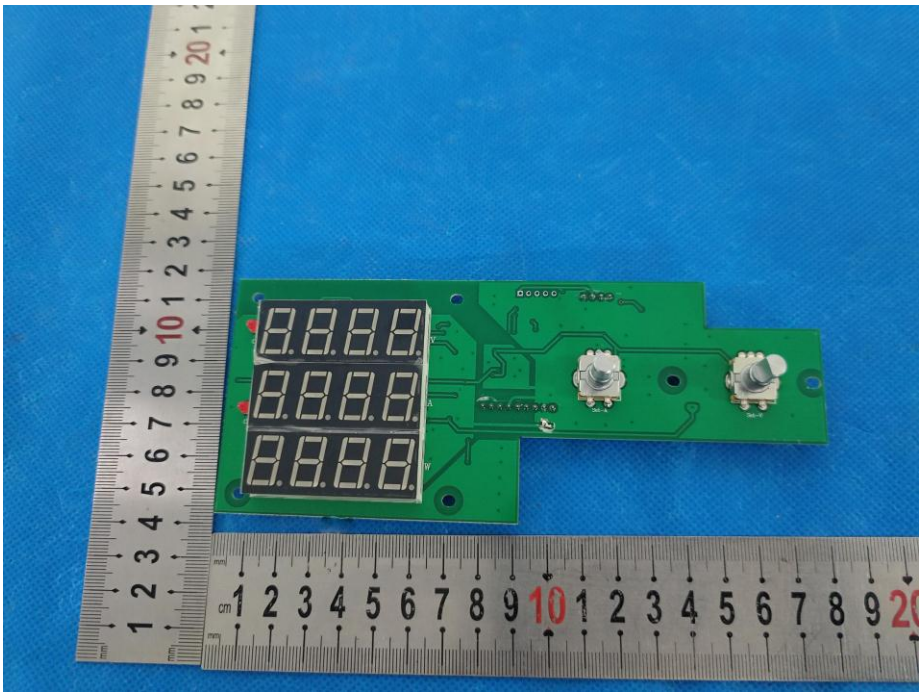
EUT Photo 3



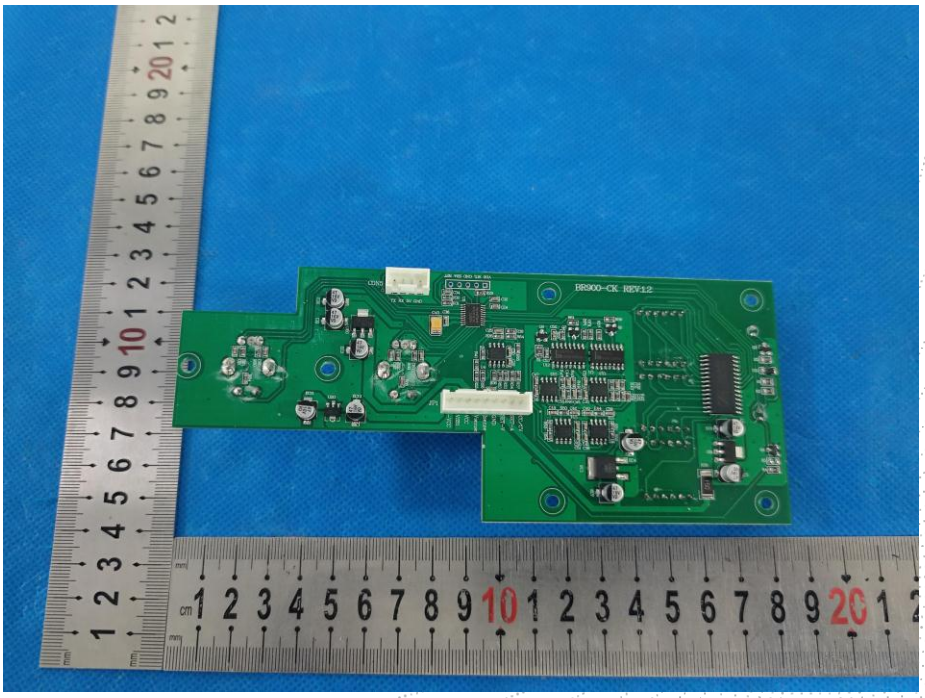
EUT Photo 4



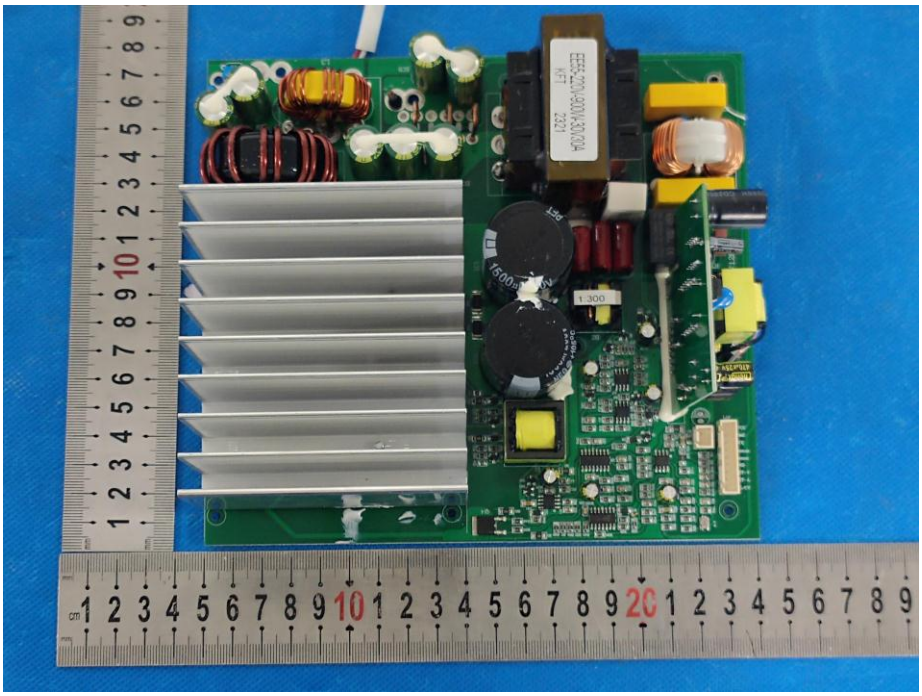
EUT Photo 5



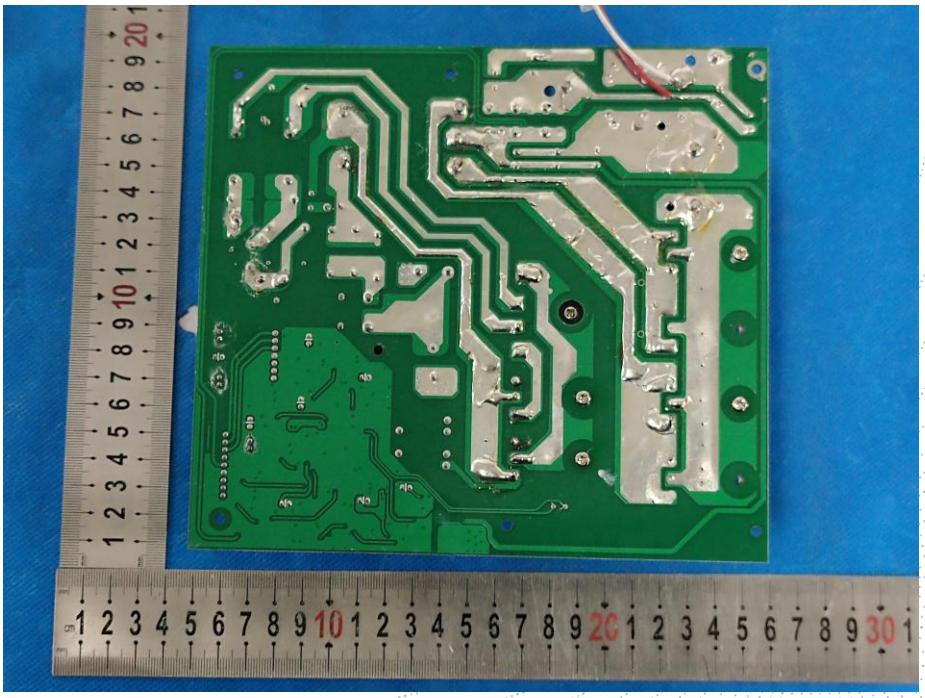
EUT Photo 6



EUT Photo 7



EUT Photo 8

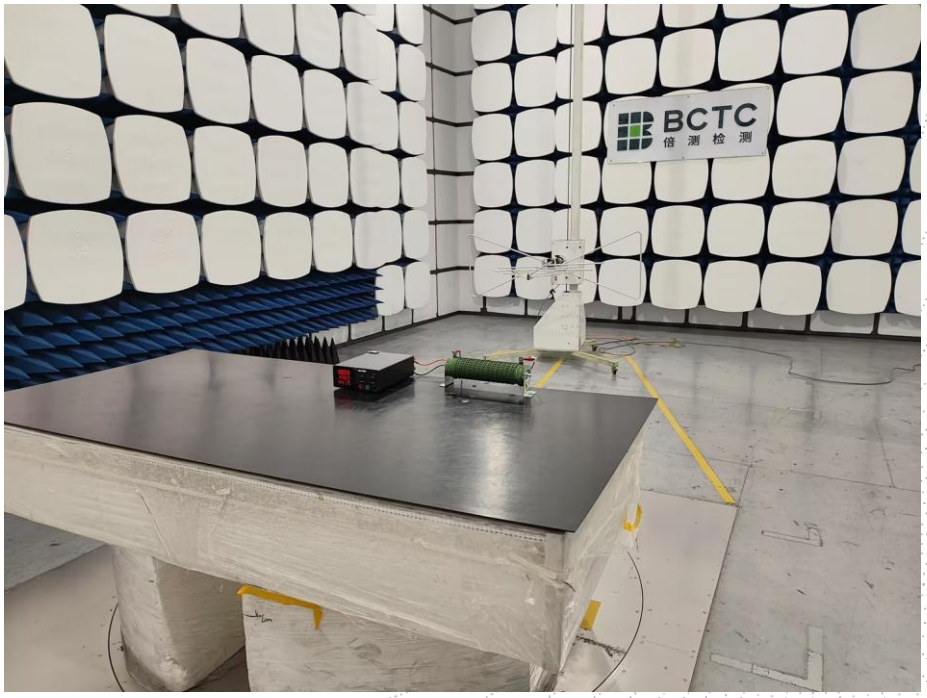


18. EUT Test Setup Photographs

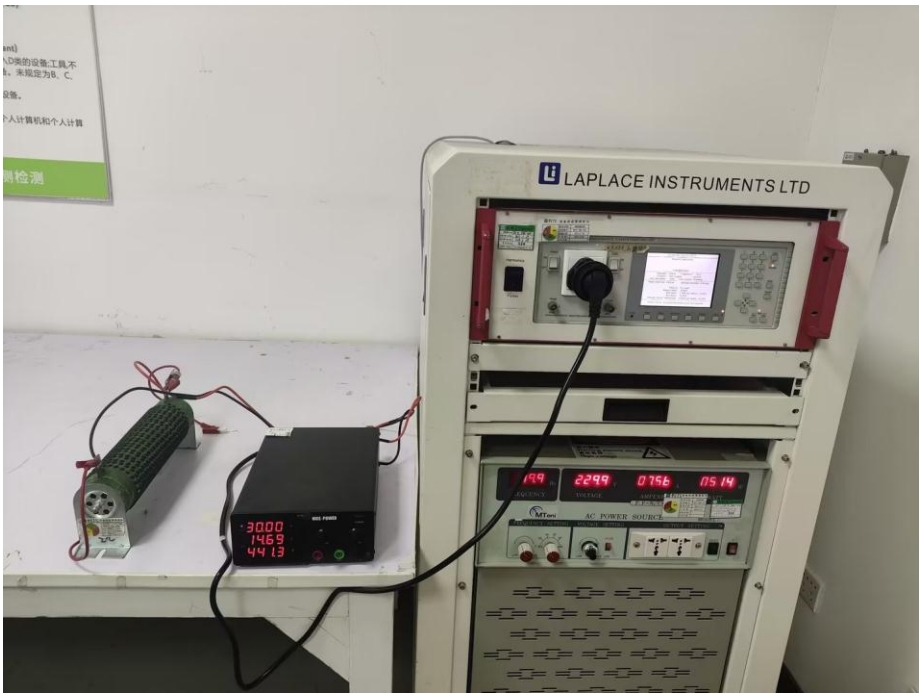
Conducted emissions



Radiated emissions



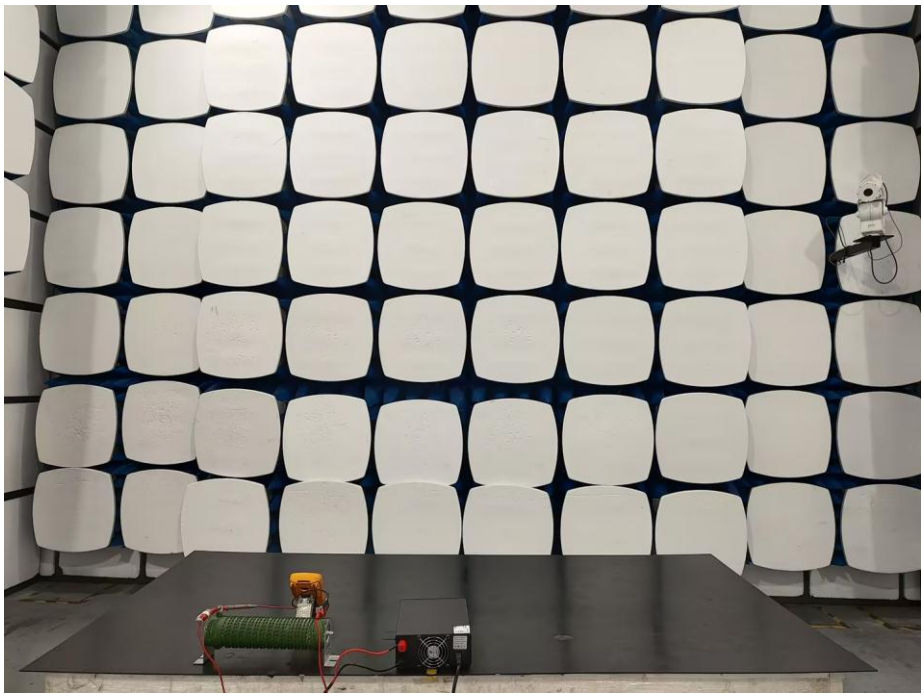
H/F



ESD



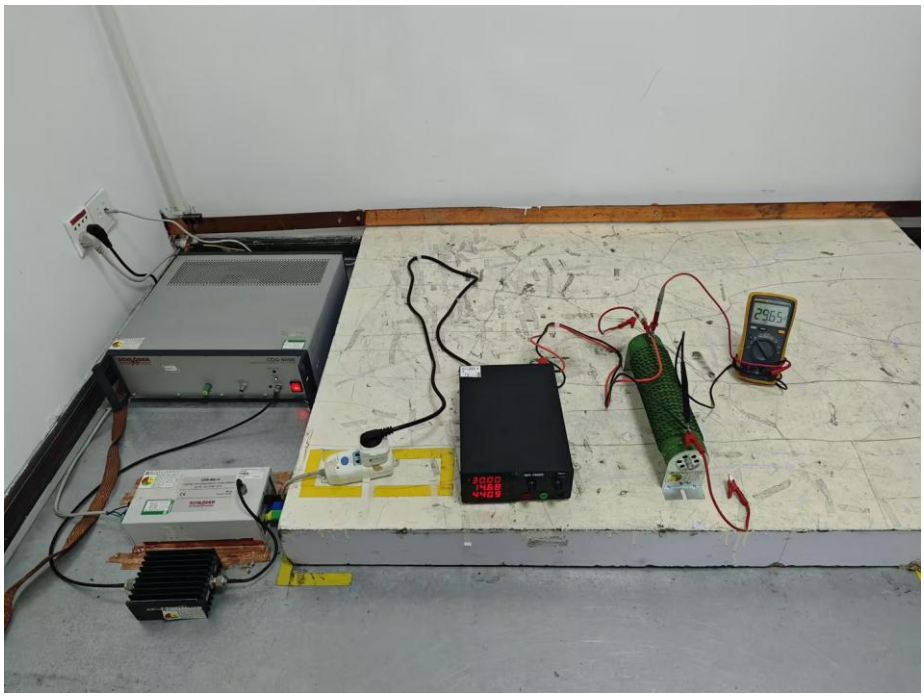
RS



EFT & Dips & Surge



CS



STATEMENT

1. The equipment lists are traceable to the national reference standards.

2. The test report can not be partially copied unless prior written approval is issued from our lab.

3. The test report is invalid without the "special seal for inspection and testing".

4. The test report is invalid without the signature of the approver.

5. The test process and test result is only related to the Unit Under Test.

6. Sample information is provided by the client and the laboratory is not responsible for its authenticity.

7. The quality system of our laboratory is in accordance with ISO/IEC17025.

8. If there is any objection to this test report, the client should inform issuing laboratory within 15 days from the date of receiving test report.

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P.C.: 518103

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Website: http://www.chnbctc.com

E-Mail: bctc@bctc-lab.com.cn

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